DC-transport in superconducting point contacts: a full counting statistics view

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W e present a comprehensive theoretical analysis of the dc transport properties of superconducting point contacts. W e determ ine the full counting statistics for these junctions, which allows us to calculate not only the current or the noise, but all the cum ulants of the current distribution. W e show how the know ledge of the statistics of charge transfer provides an unprecedented level of understanding of the di erent transport properties for a great variety of situations. W e illustrate our results with the analysis of junctions between BCS superconductors, contacts between superconductors with pair-breaking m echanism s and short di usive bridges. W e also discuss the tem perature dependence of the di erent cum ulants and show the di erences with norm al contacts.

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I. IN TRODUCTION

The current-voltage (I-V) characteristics of superconducting contacts have been the subject of investigation during the last four decades. The rst experim ental analyses were perform ed in tunnel junctions [1]. In this case the current inside the superconducting gap is suppressed, and the results can be accurately described with the BCS theory [2]. How ever, very often a signi cant current is observed in the subgap region, which cannot be explained with the simple tunnel theory. The rst anom alies were reported by Taylor and Burstein [3] who noticed a small onset in the current when the applied voltage V was equal to the energy gap, =e, in a tunneling experiment between two equal superconductors. Relatively soon afterwards it was apparent [4, 5] that not only is there an anomaly in the current at eV =, but in fact at all submultiples 2 =n, where n is an integer. This set of anom alies is referred to as subharm on ic gap structure (SGS), and its tem perature and magnetic eld dependence were thoroughly characterized [6, 7, 8].

The rst theoretical attempt to explain the SGS was done by Schrie er and W ilkins [9], who noticed that if two electrons could tunnel simultaneously, this process , and would become energetically possible at eV = cause the structure in the I-V observed by Taylor and Burstein [3]. W ithin this multiparticle tunneling theory the origin of the SGS would be the occurrence of multiple processes in which n quasiparticles cross simultaneously the contact barrier. The original perturbative analysis of this theory has serious problem s. In particular, the current was found to diverge at certain voltage, which avoids to calculate meaningful I-Vs within this approach. A second explanation was put forward by W ertham er [10], who suggested that the SGS could be caused by a selfdetection of the ac Josephson e ect. The main problem of this explanation is that it invokes two di erent mechanism s for the odd and even term s, while the experim ental current jum ps are identical for both series. In 1982 K lapw ijk, B londer and T inkham [11] introduced the concept of multiple Andreev re ection (MAR). In this process a quasiparticle undergoes a cascade of Andreev re ections in the contact interface (see Fig. 1). They showed that a MAR in which a quasiparticle crosses the interface n times becomes possible at a voltage eV = 2 = n, which explains naturally the SGS. The quantitative analysis of the I-V s was based on a sem iclassical approach which fails away from perfect transparency [12, 13]. A few years later, A mold reported the rst fully m icroscopic calculation of I-V s based on a G reen's function approach [14].

The theoretical discussion was nally claried with the advent of modern mesoscopic theories. Using the scattering form alism [15, 16, 17] and the so-called H am iltonian approach [18], dienent authors reported a complete analysis of the dc and ac Josepshon e ect in point contacts. These theories clearly showed that the M A R s are responsible of the subgap transport in these systems. They also showed that the multiparticle tunneling of Schrie er and W ilkins and the M A R s are indeed the same mechanism. The new microscopic theories have also allowed the calculation of a series of properties such as resonant tunneling [19, 20], shot noise [21, 22] and the Shapiro steps [23].

From the experim ental point of view, the main problem has always been the proper characterization of the interface of the superconducting contact. Uncertainties in the interfaces properties often avoid a proper com parison between theory and experiment. The situation has considerably improved with the appearance of the m etallic atom ic-sized contacts, which can be produced by means of scanning tunneling microscope and breakjunction techniques [24, 25, 26, 27, 28, 29, 30, 31, 32]. These nanow ires have turned out to be ideal system s to test the modern transport theories in mesoscopic superconductors. Thus, for instance Scheer and cow orkers [28] found a quantitative agreem ent between the measurem ents of the current-voltage characteristics of di erent atom ic contacts and the predictions of the theory for a single-channel superconducting contact [16, 18]. These experiments not only helped to clarify the origin of the SGS, but also showed that the set of the transmission coe cients in an atom ic-size contact is an enable to measurement. This possibility has recently allowed a set of experiments that comment the theoretical predictions for transport properties such as supercurrent $\beta 1$, noise $\beta 2$ and even resonant tunneling in the context of carbon nanotubes [33]. From these combined theoretical and experimental e orts a coherent picture of transport in superconducting point contacts has emerged with multiple Andreev rejust as a coherent concept.

The most recent development in the understanding of the dc transport in superconducting contacts is the analysis of the full counting statistics [34, 35]. Full counting statistics (FCS) is a familiar concept in quantum optics (see for instance [36]), which has been recently adapted to electron transport in mesoscopic conductors by Levitov and cow orkers [37]. FCS gives the probability P (N) that N charge carriers pass through a conductor in the m easuring tim e. Once these probabilities are known one can easily compute not only the mean current and noise, but all the cum ulants of the current distribution. Since the introduction of FCS for electronic systems, the theory has been sophisticated and applied to many di erent contexts (see Ref. [38] for a recent review).

The counting statistics of a one-channel quantum contact has the surprisingly simple form of a binom ial distribution P (N) = $\frac{M}{N} T^{N}$ (1 $T \overset{M}{,} \overset{N}{,}$, where T is the V is the number of transm ission probability and M attem pts [37, 39]. The generalization to many contacts and/or nite tem peratures is straightforward, by noting that di erent energies and channels have to be added independently. In this way, the counting statistics of di usive contacts at zero tem perature [40] and at nite tem peratures [41] could be obtained using the universal distribution of transmission eigenvalues [42, 43]. It is worth to note, that the FCS in the lim it of sm all transparency reduces to a Poisson distribution, which can also be obtained using classical argum ents and neglecting correlations between the di erent transfer events. Interestingly, the Poissonian character allows to directly extract the charge of the elem entary event, which can be used to determ ine e.g. fractional charges [44, 45, 46]. A general approach to obtain the counting statistics of mesoscopic condutors was form ulated by Nazarov [41] using an extension of the Keldysh-Green's function method, which allow ed to present the counting statistics of a large class ofquantum contacts in a uni ed m anner [47]. In R ef. [34] we have shown, how this method can be used for a timedependent transport problem like a superconducting contact out of equilibrium .

The counting statistics of a contact between a normal metal and a superconductor at zero temperature and eV was shown to be again binomial with the important di erence that only even numbers of charges are transferred [48]. The probability of an elementary event is then given by the Andreev rejection coeccient $R_A = T^2 = (2 - T)^2$ [49]. Again, the generalization of this

result to many channel conductors is obtained by sum ming over independent channels. For a di usive m etal the resulting statistics was shown to be an exact replica of the corresponding statistics for norm aldi usive transport, provided the double charge transfer is taken into account [50]. This holds for coherent transport eV Ε_{Th}, where E_{Th} is the inverse di usion time, as well as in the fully incoherent regime eV E_{Th} [51]. For interm ediate voltages, correlations of transm ission eigenvalues at di erent energies modify the distribution of transmission eigenvalues [52], which lead to a nonuniversal behavior of the transport statistics, predicted theoretically [53] and con med experimentally [54]. Here, we note that a doubling of the noise was experim entally observed in di usive wires [55], con ming earlier theoretical predictions [56]. However, to trace this back to a doubling of the elem entary charge transfer follows only from an analysis of the counting statistics. A direct experim ental determ ination of the doubled charge transfer was recently perform ed in a conductor containing a tunnel junction [57]. Here, the underlying statistics is Poissonian and the noise directly gives access to the charge of the elementary event [58, 59].

An interesting problem occurs, when one applies the concept of counting statistics to a supercurrent through a quantum contact [47]. The resulting statistics can not be directly related to a probability distribution, since some of the 'probabilities' would be negative. A closer inspection of the form alism showed, that the interpretation of probabilities relies on the proper de nition of a quantum m easuring device [60, 61, 62]. As we will see below, in superconducting contacts out of equilibrium these problem s do not occur and all probabilities are positive.

In Ref. [34] we have demonstrated that the charge transport in superconducting point contacts out of equilibrium can be described by a multinom ial distribution of processes in which a multiple charge is transferred. More in portantly, we have shown that the calculation of the FCS allows us to identify the probability of the individualMARs and the charge transferred in these processes. This information probably provides the deepest insight into the transport properties of these systems. In this sense, in this work we present a comprehensive analysis of the dc transport properties of superconducting point contacts from the point of view of the FCS.We shall show that even in the most well-studied situations the FCS provides a fresh view. Moreover, we show that the FCS allows a unied description of many dierent type contacts. W e also extend the analysis presented in R ef. [34] to nite tem perature.

The paper is organized as follows. In section II, after introducing some basic concepts of charge statistics, we discuss the calculation of the cum ulant generating functional within the K eldysh-G reen's function approach. Section III is devoted to the calculation of the M A R probabilities at zero tem perature. We present both the results of a toy m odel and the full expressions. In section IV we apply the results of the previous section to describe the di erent transport properties of three di erent

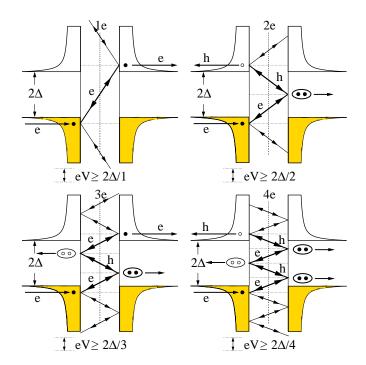


FIG.1: Schematic representation of the MARs for BCS superconductors with gap . We have sketched the density of states of both electrodes. In the upper left panel we describe the process in which a single electron tunnels through the system overcom ing the gap due to a voltage eV 2. The other panels show MARs of order n = 2;3;4. In these processes an incom ing electron at energy E undergoes at least n 1 A ndreev re ections to nally reach an empty state at energy E + neV. In these MARs a charge ne is transferred with a probability, which for low transparencies goes as Tⁿ. At zero tem perature they have a threshold voltage eV = 2 = n. The arrows pointing to the left in the energy trajectories indicate that a quasiparticle can be norm alre ected. The lines at energies below E and above E + neV indicate that after a detour a quasiparticle can be backscattered to nally contribute to the MAR of order n.

situations: (i) a contact between BCS superconductors, (ii) a contact between superconductor with a modi ed density of states due to a pair-breaking mechanism s, and (iii) a short di usive SNS contact. In section V we analyze the transport at nite temperature paying special attention to the third cum ulant. Finally, we present our conclusions in section V I.

II. DESCRIPTION OF THE FORMALISM

A. Som e basic concepts

O ur goal is to calculate the full counting statistics of a superconducting contact. This means that the quantity that we are interesting in is the probability P_{t_0} (N), that N charges are transferred through the contact in the time interval t_0 . Equivalently, we can d the cum ulant generating function (CGF) S_{t_0} (), which is simply the

logarithm of the characteristic function and is de ned by

$$\exp \left(S_{t_0} \left(\begin{array}{c} \end{array} \right) \right) = \left(\begin{array}{c} X \\ P_{t_0} \left(N \right) \right) \exp \left(i N \right) : \quad (1)$$

Here, is the so-called counting eld. From the knowledge of the CGF one easily obtains the dierent cumulants that characterize the probability distribution

$$C_{n} = (\dot{1})^{n} \frac{\dot{e}^{n}}{\dot{e}^{n}} S_{t_{0}} (\dot{1}) = 0$$
 (2)

Notice that the $\;$ rst cumulants are related to the moments of the distribution as follows

$$C_{1} = \overline{N} \qquad \begin{array}{c} X \\ N P_{t_{0}} (N) ; C_{2} = \overline{(N \ \overline{N})^{\beta}}; \\ C_{3} = \overline{(N \ \overline{N})^{\beta}}; C_{4} = \overline{(N \ \overline{N})^{4}} \qquad 3C_{2}^{2}; (3) \end{array}$$

and so on. It is also in portant to remark that these cumulants have a simple relation with the relevant transport properties that are actually measured. Thus, for instance, the mean current is given by $I = (e=t_0)C_1$ and the symmetrized zero frequency noise is given by $S_I = (2e^2=t_0)C_2$ [75]. For higher cumulants such relations are not straightforwardly obtained, but it can be shown that the cumulants de ned above correspond to the observable quantities in an electron counting experiment [47, 60, 61]. Thus, the cumulants represent all information, which is available in a measurement of the charge accumulated during the observation period t_0 .

B . Keldysh-G reen's function approach to FCS

A sm entioned above, our system of interest is a voltagebiased superconducting point contact, i.e. two superconducting electrodes linked by a constriction, which is much shorter than the superconducting coherence length. W e concentrate ourselves on the case of a single channel contact described by a transm ission probability T. Them ain di culty in the determ ination of the FCS arises from the ac-Josephson e ect. Here, a constant applied bias voltage eV gives rise to tim e-dependent currents as a consequence of the Josephson relation (Q=Qt) (t) = 2eV=. In ~=eV these oscillating currents the long-time lim it to do not contribute to the net charge transfer, in which we are interested. However, this intrinsic time-dependence is relected in the CGF and a little care has to be taken, when the FCS is de ned.

To obtain the FCS in a superconducting point contact we make use of the K eldysh-G reen's function approach to FCS introduced by Nazarov and one of the authors [41, 47], and we refer to reader to these papers for further details on the basis of this theoretical approach. In what follows, we concentrate ourselves on the speci c di culties introduced in the case of a contact between two superconductors. O ur starting point for the determ ination of the CGF is to de ne the relation between the CGF and the counting current in analogy to Refs. [41, 47]:

$$\frac{\underline{\theta}}{\underline{\theta}}S_{t_0}(\cdot) = \frac{\underline{i}}{\underline{e}} \int_{0}^{Z_{t_0}} dt I(\cdot; t): \quad (4)$$

This scalar current can be calculated in term s of the matrix current which describes the transport properties of the contacts. Nazarov has shown that, in the case of short junctions the matrix current (in Keldysh-Nambu space) adopts the following form [63]

$$I(;t;t^{0}) = \frac{e^{2}}{4+T \ fG_{1}();G_{2}g_{2}} (t;t^{0}):$$
(5)

Here $G_{1(2)}(t;t^0)$ denote the matrix G reen's functions on the left and the right of the contact. In our problem these functions depend on two time arguments and the products appearing in Eq. (5) should be understood as convolutions overathe intermediate time arguments, i.e. (A B)(t;t) = dt⁰A(t;t⁰)B(t⁰;t⁰). It is worthwhile to note, that the derivation for the matrix current in Ref. [63] was done for G reen's functions in the static situation, in which case all G reen's functions depend only on t ℓ . However, the derivation can be directly taken over to time-dependent problem s, because the time-dependent G reen's functions satisfy the norm alization condition

$$(G G)(t;t^0) = (t \quad 0):$$
(6)

F inally, the time-dependent scalar current is obtained from the matrix current by

$$I(;t) = \frac{1}{4e} Tr_{K} I(;t;t) ;$$
 (7)

where $_{K} = ^{3}_{3}$ is a matrix in Keldysh(')-Nambu() space. $^{i}(i)$ are the standard Pauli matrices in Keldysh(Nambu)-space.

Let us now describe G reen's functions entering Eq. (5). The counting eld is incorporated into the matrix G reen's function of the left electrode as follows

$$G_{1}(;t;t^{0}) = e^{i_{\kappa}^{2}}G_{1}(t;t^{0})e^{i_{\kappa}^{2}}$$
 (8)

Here G_1 (t;t⁰) is the reservoir G reen's function in the absence of the counting eld. We set the chem ical potential of the right electrode to zero and represent the G reen's functions by

$$G_{1}(t;t^{0}) = e^{i(t)_{3}=2}G_{S}(t,t^{0})e^{i(t^{0})_{3}=2}$$
 (9)

and $G_2(t;t^0) = G_S(t-t^0)$. Here, $(t) = _0 + (2eV =)t$ is the time-dependent superconducting phase di erence, and $_0$ is its dc part. G_S is the G reen's function of a superconducting reservoir (we consider the case of a sym - m etric junction), which reads

$$G_{s}(t \quad t^{0}) = dE G_{s}(E)e^{iE(t \quad t^{0})}; \quad (10)$$

$$G_{s}(E) = (A \quad R)f + R \quad (A \quad R)f \\ (A \quad R)(1 \quad f) \quad R \quad A)f + A :$$

Here, R (A) (E) are retarded and advanced G reen's functions of the leads and f (E) is the Ferm i function. A d-vanced and retarded functions in (10) have the Nam bustructure R (A) = $g^{R,A}_{3} + f^{R,A}_{1}$ fulling the norm alization condition $f^{2} + g^{2} = 1$. They depend on energy and the superconducting order parameter .

U sing the time dependence of the leads G reen's functions it is easy to show from Eq. (5) that the scalar current adm its the following Fourier series

$$I(;t) = \sum_{n=1}^{N} I_{n}()e^{in}(t);$$
 (11)

which m eans that the current oscillates with all the harmonics of the Josephson frequency. It is important to stress that the components I_n () are independent of dc part of the superconducting phase. In this work we only want to consider the dc part of the CGF. For this purpose, we take the lim it of a long measuring time t_0 , much larger than the inverse of the Josephson frequency, and hereafter we drop the subindex t_0 in the expression of the CGF. From Eq. (4) and Eq. (11) it is obvious that by selecting the dc component, the dc part of the phase drops the calculation and the CGF is free of the problem s related to gauge invariance found for the dc Josephson effect [47, 60, 64].

K exping in m ind the presence of the time integration described aboved, and with the help of Eqs. (5-7), one can integrate Eq. (4) to obtain the following expression for the CGF of superconducting constrictions [47]

S() =
$$\frac{t_0}{h}$$
Trln 1 + $\frac{T}{4}$ fG₁();G₂g 2 : (12)

The symbol implies that the products of the G reen's functions are convolutions over the internal energy arguments, i.e.

$$(G_1 G_2) (E; E^0) = dE_1 G_1 (E; E_1) G_2 (E_1; E^0) : (13)$$

The trace runs not only over the K eldysh-N am bu space, but also includes a trace in the energy arguments, i.e. dE g(E;E).

The time-dependent G reen's functions of Eq. (8) full the normalization condition of Eq. (6). This enables us to use the relation

$$2 \text{ fG}_{1}; \text{G}_{2}\text{g} = \text{G}_{1} \text{ G}_{2}^{2} \qquad (14)$$

to write the CGF as

$$S() = \frac{t_0}{h} Tr \ln Q_+ + \ln Q_-;$$
 (15)

where Q $1 \quad (T=2) G_1() G_2$. One can show that both logarithms give the same contribution, and therefore we concentrate in the analysis of the rst one, and we drop the subindex + . Additionally, we use the relation TrhQ = h detQ to write the CGF as

$$S() = \frac{t_0}{h} \ln \det Q()$$
: (16)

Thus, at this stage the calculation reduces to the calculation of the determ inant of a in nite matrix. Due to the time dependence of the lead G reep's functions their form in energy space is G (E; E⁰) = ${}_{n} G_{0;n}$ (E) (E E⁰ + neV), where n = 0; 2. This im plies that the matrix Q also admits the same type of representation, which in practice ${\tt m}$ eans that ${\tt Q}\;$ is a block-tridiagonal ${\tt m}$ atrix of the form

where we have used the notation $Q_{n,m} = Q (E + neV; E + m eV)$. The di erent (4 4) matrices $Q_{n,m}$ have the following explicit form in terms of the advanced and retarded G reen's functions $g^{R,A}$ and $f^{R,A}$ (rem ember that we consider a symmetric junction)

where we have used the shorthand notation $g_n^{R,i^A} = g^{R,i^A}$ (E + neV), = $(g^A \quad g^R)f$, f being the Ferm i function, ~ = $(f^A \quad f^R)f$, = $(g^A \quad g^R)(1 \quad f)$, and ~ = $(f^A \quad f^R)(1 \quad f)$.

O ne can restrict the fundamental energy interval to $E = E^0 2 \ [0;eV]$, and therefore the CGF adopts the form S () = $(t_0=h) \frac{R_{eV}}{0} dE \ h detQ$. From Eq. (17), it is obvious that detQ can be written as the following Fourier series in

detQ() =
$$P_n^0 (E; V) e^{in}$$
; (18)

where the coe cients P $_{n}^{0}$ (E;V) have still to be determined. K exping in m ind the norm alization S (0) = 0, it is clear that one can rewrite the CGF in the following form

S() =
$$\frac{t_0}{h} \begin{bmatrix} z & eV \\ 0 & dE \ln 1 + \\ 0 & n = 1 \end{bmatrix} P_n (E; V) e^{in} = 1;$$

(19)

where

$$P_{n} (E; V) = P_{n}^{0} (E; V) = \prod_{n=1}^{n \times 1} P_{n}^{0} (E; V):$$
 (20)

Eq. (19) has the form of the CGF of a multinom ial distribution in energy space (provided more than one P_n is di erent from zero). The di erent terms in the sum in Eq. (19) correspond to transfers of multiple charge quanta ne at energy E with the probability P_n (E;V), which can be seen by the (2 =n)-periodicity of the accompanying -dependent counting factor. This is the m ain result of our work and it proves, that the charges are indeed transferred in large quanta. O focurse, we still have to determ ine the probabilities P_n (E;V), which is a non-trivial task and it will the goal of the next section.

C. Cumulants

A s explained before, from the CGF one can easily calculate the cum ulants of the distribution and in turn m any transport properties. Of special interest are the rst three cum ulants C_1 , C_2 and C_3 , which correspond to the average, width and skew ness of the distribution of transmitted charge, respectively. From Eq. (2) and Eq. (19), it follows that these cum ulants can be expressed in terms of the probabilities P_n (E;V) as follows

$$C_{1} = \frac{t_{0}}{h} \overset{Z_{ev}}{\overset{W}{\underset{M}{}}} \overset{X}{\underset{M}{}} nP_{n}; \qquad (21)$$

$$C_{2} = \frac{t_{0}}{h} \frac{dE}{dE} = n^{2}P_{n} \qquad nP_{n}; \qquad (22)$$

$$C_{3} = \frac{t_{0}}{h} \overset{Z_{eV}}{_{0}} \overset{< X}{_{n}} \overset{X}{_{n}} \overset{X}$$

These expressions are a simple consequence of the fact that the charge transfer distribution is multinom ial in energy space. At zero temperature the sum s over n are restricted to positive values (n 1). We remaind the reader that the rst two cumulants are simply related to the dc current, $I = (e=t_0)C_1$, and to the zero-frequency noise $S_I = (2e^2=t_0)C_2$.

It is instructive to discuss som e consequences of these expressions. Let us rst recall, what happens when only one process contributes, which has, e.g., the order n. The rst three cum ulants are

$$C_{1;n} = n \sum_{0}^{Z_{eV}} \frac{t_0 dE}{h} P_n;$$
 (24)

$$C_{2;n} = n^2 \frac{t_0 dE}{h} P_n (1 P_n);$$
 (25)

$$C_{3,n} = n^3 \frac{t_0 dE}{h} P_n (1 P_n) (1 2P_n) : (26)$$

W e see, that the i^{th} cumulant is proportional n^i , i.e. the i^{th} power of the charge of the respective elementary event. The expressions under the integral in Eqs. (24-26) have the same form as for binom ial statistics, how ever in

general the $P_n \times V$) depend on energy in a nontrivial way and the energy-integrated expressions for the cum ulants do not correspond to binom ial statistics. A simple interpretation in terms of an elective charge transferred is only possible if $P_n (E; V)$ 1 for all energies, in which case one recovers the standard result for Poisson statistics, $C_{i,n} = n^{i-1}C_{1,n}$. A coording to Eq. (26) the sign of the spectral third cum ulant can be positive or negative, depending on the size of P_n (positive for $P_n < 1=2$ and negative for $P_n > 1=2$). The overall sign depends on the energy average and is not simple to predict. Note, how ever, that the probabilities of MAR-processes of higher orders decrease approximately as Tⁿ. We may therefore speculate that to obtain a negative third cum ulant for higher order processes we will need more open contacts (a rough estimate is thus that T & $1=\frac{1}{2}$ to have $P_n \& 1=2 \text{ and, therefore, } C_3 < 0$).

The general statistics (19) is a multinom ial distribution and it is therefore interesting to compare with independent binom ial distributions. This is most easily done by assuming, that only two processes compete. Taking these processes to be of order n and m the rst three cum ulants read

$$C_{1,mm} = C_{1,m} + C_{1,m}$$
; (27)

$$C_{2\mu m} = C_{2\mu n} + C_{2\mu n} \qquad 2nm \qquad \frac{t_0 dE}{h} P_n P_m ; \qquad (28)$$

$$C_{3,nm} = C_{3,n} + C_{3,m} \quad 3nm \int_{0}^{2 \text{ eV}} \frac{t_0 dE}{h} P_n P_m [n (1 P_n) + m (1 P_m)]:$$
(29)

We see that the rst cumulant is just the sum of the contributions of the di erent processes n and m and we therefore have to look at higher cumulants to gain inform ation on correlations between the processes of di erent order. In both, the second and the third cumulant, such correlations appear and it is evident from Eqs. (28) and (29) that both are reduced below the value obtained for independent binom ials. The correlation terms appear inside the energy integration and therefore both processes m ust be possible at the same energy.

Finally, we note that in order to study correlation between N di erent processes one would have to look at the N th order cum ulant. This becomes clear if one notices that only the N th cum ulant contains a term with products of N probabilities and therefore the possibility to have a product of probabilities of N di erent processes.

III. M AR PROBABILITIES:ZERO TEM PERATURE

This section is devoted to the calculation of the probabilities P_n (E;V) at zero temperature. First, we discuss a simplem odelwhich nicely illustrates the transmission dependence of these probabilities, and secondly we present the general expressions.

A. Toy model

To obtain a feeling for the forthcom ing calculations we will now study a strongly sim pli ed m odel of a superconducting contact. For that purpose, let us assume that we can neglect the Andreev re ections for energies outside the gap region and replace the quasiparticle density of states by a constant for $\pm j > \ldots$ Furtherm ore, we neglect that energy-dependent phase shift $a\cos(E =)$, usually associated with the nite penetration of excitations close to the gap edge. M athem atically, this m eans that we set $f^{R;A}$ (E j <) = 1, $g^{R(A)}$ (E j >) = 1, and both are equal to zero otherwise. This sim pli es the calculation a lot, since the matrix Q in Eq. (16) now becomes nite. In particular, for subharm onic voltage eV = 2 = n the matrix is also energy-independent. It is interesting to note that the toy model is also able to describe the counting statistics of norm al contacts and Andreev contacts.

super:	E >	јј> Е	> E
norm al:	E > eV		E < eV
ĝ ₁₁ ()	Ŕ ()	0	Ќ+ ()
ĝ ₂₂ ()	Ŕ ()	0	Ќ+ ()
ĝ ₁₂₍₂₁₎ ()	0	e ^{i 3}	0

TABLE I: G reen's functions in the toy model. The indices \hat{g} denote the respective element in N am bu space. $\hat{K} = \hat{g}$ 2^ e ⁱ denotes a matrix in K eldysh space. The table holds for left and right term inal, provided the energies and

the counting elds are chosen properly.

To facilitate the discussion of the matrix structure it is useful to introduce the 2 $\,$ 2 matrix in the K eldysh subspace

$$\hat{K}$$
 () = $\hat{3}$ 2^ eⁱ; (30)

where \hat{i} are Pauli matrices and $\hat{i} = (\hat{i} + \hat{i}) = 2$. In fact, \hat{K} correspond to occupied (empty) quasiparticle states (for E > j). The matrix structure for superconducting or normal term inals is sum marized in Table I. The counting statistics is obtained from the general relation (16)

$$S(;V) = \frac{2t_0}{h} \int_{0}^{Z_{eV}} dE Tr \ln 1 + \frac{p_{T}}{2} G_1() G_2 :$$
(31)

The incorporation of the energy discretization is obtained by a rede nition of the trace in the above form ulas, and a limitation of the energy integration to an interval of width eV . Note, that we have to evaluate only one of the two term $\sup_{T} Q_{T}$, since the FCS can only depend on T and not on T.

To calculate the determ inant we note that Q is a band m atrix of width 3 in the energy index. Then the following reduction form ula for the determ inant is useful (assuming a block starts at som en, which we arbitrarily set to zero):

A nother useful property (which holds in the toy model) is the Nam bu structure of the Q's, see Eq. (17) and Table I: diagonal components in energy space, i. e. $Q_{n;n}$, are always block-diagonal in Nam bu space and the o-diagonal components $Q_{n;n}_2$ are purely o-diagonal in N am bu space and diagonal in K eldysh-space. Consequently, $Q_{n-2;n-2} = Q_{n-2;n}Q_{n;n}^{-1}Q_{n;n-2}$ appearing in the expansion of the determ inant is block-diagonal again and the whole calculation of the determ inants and inversions of 2 2-m atrices. This will become more clear, when we will treat the explicit examples below.

1. Norm alContact

It is instructive to dem onstrate the procedure st for a norm alcontact. The G reen's functions are (we restrict the calculation here to electron block, the hole block gives actually the same contribution)

$$\hat{G}_{1} = \begin{array}{ccc} \hat{K} & (\) \ ; \ n & 0 \\ \hat{K}_{+} & (\) \ ; \ n < 0 \end{array} ; \\ \hat{G}_{2} = \begin{array}{ccc} \hat{K} & (0) \ ; \ n > 0 \\ \hat{K}_{+} & (0) \ ; \ n & 0 \end{array} ;$$
(33)

Note that we have chosen the fundam ental energy interval [eV=2;eV=2], since then the G men's functions are constant inside each interval. Then we nd

$$\frac{(\hat{Q}_{p} 1_{h,m})}{\overline{T}=2} = n_{m} \frac{\hat{Q}_{r}}{\hat{T}} + \hat{Q}_{r}^{i} + \hat{Q}_{$$

The matrix Q has thus block diagonal form. The blocks n > 0 and n < 0 are tridiagonal and the determ inants are all equal to 1. The remaining determ inant of the n = 0 block is

det
$${}^{1+p}\frac{p}{T} \frac{T}{p}\frac{p}{T}\frac{p}{p}\frac{T}{T} = 1 \quad T + Te^{i}$$
: (35)

The CGF is nally S () = $(2eV t_0=h) \ln (1+T (e^i 1))$ in agreement with Levitov and Lesovik [37]. Notice that a factor of 2 enters the CGF, because we get an additional contribution from the hole block (thus it is due to spin).

2. Andreev contact

We now consider a contact in which one of the sides is superconducting and the other is a norm alm etal. A gain, the calculation can be done in a sim ilar way. Here we apply a voltage jeV j to the norm al contact. The G reen's functions are again diagonal in the energy space, since we assume that the superconductor is at zero potential. For the norm alm etalwe nd (taking as fundam ental energy interval [eV; eV])

$$\hat{G}_{1} = \hat{K} (); n = 0;$$

$$\hat{K}_{+} (); n < 0;$$

$$\hat{G}_{1} = \hat{K} (); n > 0;$$

$$\hat{G}_{1} = \hat{K} (); n > 0;$$

$$\hat{K}_{+} (); n = 0;$$
(36)

and for the superconductor $\hat{G}_2 = \hat{G}_2 = \hat{f}_1$ and 0 otherw ise. The only non-zero block is the n = 0 energy block

$$G_1()$$
 $G_2 = \begin{pmatrix} K & () & 1 \\ 1 & K_+ & () \end{pmatrix}$; (37)

which yields for the CGF in the form (12) the determ inant of

$$Q = \frac{1}{\frac{T}{4}} \frac{\frac{T}{2}}{(K_{+}^{2} + K_{-}^{2})} \frac{\frac{T}{4}}{(K_{+}^{2} + K_{-}^{2})} \frac{1}{\frac{T}{2}}$$
(38)

To calculate the determ inant we subtract from row s3 and 4 the row s1 and 2 multiplied with $\frac{T}{4} (1 \quad \frac{T}{2}) (\hat{K_+} \quad \hat{K_-})$ and m ake use of the fact that $(\hat{K_-} \quad \hat{K_+})^2 = 4 (1 \quad e^{j2})$. The m atrix is then tridiagonal and its determ inant is

$$1 \quad \frac{T}{2} \quad \frac{2}{1 + \frac{T^2}{(2 - T)^2}} e^{i2} \quad 1 \quad : \quad (39)$$

The prefactor is canceled because we are operating under the ln and have to norm alize. Notice that the evaluation of the determ inant outside the transport window can be done in a similar way. One obtains for the determ inant of one block $(1 \quad T=2)^2 \quad T^2 (\vec{k} \quad () \quad \vec{k} \quad ())^2 = (1 \quad T=2)^2$, which is independent of the counting eld and is therefore canceled after norm alization of the CGF. Finally we obtain for the FCS (collecting all prefactors) [48]

S() =
$$\frac{2\text{eV}t_0}{h}\ln 1 + \frac{T^2}{(2 T)^2}e^{i2}$$
 1: (40)

The statistics corresponds to a binom ial distribution of charge transfers. The Andreev re ection leads to a – periodicity in which shows that only couples of charges can be transferred and the charge transfer probability for odd charge num bers vanishes. The num ber of attem pts, determ ined by the prefactor of the ln in (40), remains unchanged in com parison to the norm al case.

3. Superconducting point contact

We now come to the main subject of the article, a point contact between two superconducting banks held at di erent chem ical potentials. To write down the generalm atrix structure of the FCS in the toy model, let us rst obtain the condition for energies to be subgap. Here, we restrict ourselves to subharm onic voltages, which we write in general as eV = 2 = (N)1), where N denotes the order. The dom inating charge transport mechanism we expect is that N charges are transferred. In the toymodel, it is the only transport mechanism (since And reev re ections above the gap are neglected). To obtain a single-valued m atrix entries, it is favourable to choose as fundam ental energy interval [0; eV] for even N = 2M and [eV=2;eV=2] for odd N = 2M 1. For the Nambu row indices of the G reen's function of the left term inal we nd

N am bu	0 rder		Έj			_	
upper	odd	М	n	М	1		
upper lower	odd	М	+ 1	n	М		(41)
upper lower	even	М	1	n	М	1	
lower	even	I	М	n	М		

The row indices in Nambu space of the right G reen's functions have the energy arguments of upper and lower row interchanged.

To clarify the matrix structure we have prepared a small table. Each entry denotes the energy for the structure $\frac{\dot{g}_{1i}^L}{g_{2i}^L} \frac{\dot{g}_{1i}^R}{g_{2i}^R}$, where the second (N am bu-) index i = 1;2 plays no role. The entries are denoted by + for E > ,0 for E j , and for E < .

n	N = 2	N = 3	N = 4	N = 5	N = 6	
2	+ + +	+ + + +	+ + + +	+ 0 0 +	+ 0 0 +	
1	+ + + +	+ 0 0 +	+ 0 0 +	0 0 0 0	0 0 0 0	
0	+ 0 0 +	0 0 0 0	0 0 0 0	0 0 0 0	0 0 0 0	(42)
1	0 0	0 0	0 0 0 0	0 0 0 0	0 0 0 0	
2			0 0	0 0	0 0 0 0	
3					0 0	

W e observe that the matrix structure in all cases is sim - ilar. A block with 0 and + elements, i.e. connecting the quasiparticle states above the gap to the subgap region is followed a number of blocks inside the gap (depending on the applied voltage and, nally, is connected by a block with 0 and elements to quasiparticle states below the gap.

Let us now discuss the case N = 2 (eV = 2). Here

the relevant 8 8-m atrix is

W e observe, that the matrix decouples into two blocks of 4 - 4 matrices

$$Q_{2A} = 1 + \frac{P_{\overline{T}}}{2} \quad \hat{K} \quad () \qquad 1$$

(44)

and

$$Q_{2B} = 1 + \frac{p_{\overline{T}}}{2} \quad \vec{K} \quad (0) \quad e^{i_{3}} \\ e^{i_{3}} \quad \vec{K}_{+} \quad (0) \quad : \quad (45)$$

By comparison with Eq. (37) we see that $\ln \det_{QA}$ yields the counting statistics of usual Andreev re ection. Q_{2B} gives actually the same result. This is most easily seen, if the unitary transform ation $UQ_{2B}U^{y}$ with $U = \text{diag}(e^{i_{3}} = 2; e^{i_{3}} = 2)$ is applied, which transforms s Q_{2B} into Q_{2A} . Note, that the signs of the o-diagonal m atrices do not m atter, since they can be elim inated by sim ilar unitary transform ations. The counting statistics is therefore given by Eq. (40), the same as for the Andreev contact.

Now we come to the slightly more complicated case N = 3 (eV = 2 =2). Here we encounter the matrix

Once again, the matrix decouples into two blocks (rows 1,4,5 and rows 2,3,6). The rst block is

$$Q_{3A} = 1 + \frac{p_{\overline{T}}}{2} \begin{pmatrix} 0 & \hat{K} & () & 1 & 0 \\ 0 & 1 & 0 & e^{i_{3}} & A \\ 0 & e^{i_{3}} & \hat{K}_{+} & (0) \end{pmatrix}$$
(47)

It is already evident, that we will encounter a three particle process, if we apply the transformation $U = diag(exp(i ^{3});exp(i ^{3});1)$. This yields

$$U Q_{3A} U^{y} = 1 + \frac{p_{T}}{2} \begin{pmatrix} 0 & \hat{K} & (3) & 1 & 0 \\ 0 & 1 & 0 & 1 & A \\ 0 & 1 & \hat{K}_{+} & (0) \end{pmatrix}$$
(48)

Evaluating the determ inant we obtain the counting statistics (including the other block, see below)

S() =
$$\frac{2\text{eV} t_0}{h} \ln 1 + \frac{T^3}{(4 \ 3T)^2} e^{-i3} 1$$
: (49)

Evidently this correspond to the binom ial transfer of packages of three charges, where the probability of a third order process is $P_3 = T^3 = (4 \quad 3T)^2$. A similar procedure may be applied to the second block Q_{3B} . The result is the same. Physically, the two blocks correspond to two independent processes which dier by the spin.

For higher order processes the calculation goes in complete analogy. The property of a decoupling into two independent blocks remains. Further more it is possible to the shift the entire -dependence to the uppermost (or the lowest) block. This is achieved by a series of unitary operations of the type $(1; \ldots; 1; \exp(in \ 3); 1; \ldots; 1)$. One can easily convince oneself, that for a process of order N this gives e.g. the upper-left block K (N) and the remaining matrix is now independent of . For example a 5th-order process yields

$$1 + \frac{P - B}{2} = \begin{bmatrix} 0 & \hat{K} & (5 &) & 1 & 0 & 0 & 0 \\ 1 + \frac{P - B}{2} = \begin{bmatrix} 0 & 1 & 0 & 1 & 0 & 0 & C \\ 0 & 1 & 0 & 1 & 0 & C \\ 0 & 0 & 1 & 0 & 1 & A \\ 0 & 0 & 0 & 1 & \hat{K}_{+} & (0) \end{bmatrix}$$
(50)

Additionally, the signs of the o-diagonal element may be removed by unitary transformations. Evaluating the determinant we nd S() = $(2eV t_0=h) \ln 1 + P_5 e^{in} 1$, where $P_5 = T^5 = (16 \quad 20T + 5T^2)^2$. This expression describes binomial transfers of 5 charges with probability P_5 .

U sing the above scheme, it is also possible to derive recursion relations for the probabilities. We not the probability for a process of order N

$$P_{N} = \frac{1}{1 + \frac{1 + \frac{p_{T}}{2}}{1 + \frac{p_{T}}{2}} + \frac{1}{N} + \frac{1}{2} + \frac{p_{T}}{2}}{p_{T} + \frac{1}{4} + \frac{p_{T}}{2}} + \frac{1}{N} + \frac{p_{T}}{4}}$$
(51)

The factors and are determined from the recursion relations

$$_{n} = 1 \quad \frac{T}{4_{n-1}} \quad ; \quad _{n} = \frac{T}{4} \frac{_{n-1}}{_{n-1-n-1}} ; \quad (52)$$

with the initial conditions

$$_{1} = {}^{p}\overline{T}$$
; $_{1} = 1$ $\frac{{}^{p}\overline{T}}{2}$: (53)

n

For general subharm onic voltages 2 = (N - 1) we not the counting statistics

$$S() = \frac{2eV t_0}{h} \ln 1 + P_n e^{in} 1 ;$$
 (54)

where the probabilities are given by

$$P_{2} = \frac{T^{2}}{(2 T)^{2}}; \qquad (55)$$

$$P_{3} = \frac{T^{3}}{(4 3T)^{2}}; \qquad (55)$$

$$P_{4} = \frac{T^{4}}{(8 8T + T^{2})^{2}}; \qquad P_{5} = \frac{T^{5}}{(16 20T + 5T^{2})^{2}}; \qquad P_{6} = \frac{T^{6}}{(2 T)^{2}(16 16T + T^{2})^{2}}; \qquad P_{7} = \frac{T^{7}}{(2 T)^{2}(16 16T + T^{2})^{2}}; \qquad P_{7} = \frac{T^{7}}{(16 16T + T^{7})^{2}}; \qquad P_{7} = \frac{T^{7}}{($$

Note the limiting cases of these probabilities P_N $T^N=\!4^{N-1}$ for T-1 and P_N = 1 for T = 1.

We can draw several conclusions from the toy model. First we obtain simple expressions for the probabilities of multiple charge $P_{\rm N}$, which are not simple products of Andreev re ection probabilities and quasiparticle transmissions, see Eq. (55). Furtherm ore it is interesting to note that by virtue of the unitary transform ations we can interpret the charge transfer as simultaneous transmission of N quasiparticles. This explanation does not invoke any kind of combined transfer of C ooper pairs and quasiparticle.

B. Full expressions

Let us now discuss the full expression of the probabilities $P_n (E; V)$ at zero temperature. Since Q has a block-tridiagonal form, in order to calculate its determ inant we can use the a recursion technique similar to the one describe for the toy model. We dene the following 4 matrices

$$F_{n} = Q_{n; n} Q_{n; n} {}_{2}F_{n}^{1} {}_{2}Q_{n} {}_{2; n}; n 2$$

$$F_{0} = Q_{0;0} Q_{0; 2}F_{2}^{1}Q_{2;0} Q_{0;2}F_{2}^{1}Q_{2;0}; (56)$$

W ith these de nitions, detQ is simply given by detQ = $\int_{j=1}^{1} detF_{2j}$. In practice, detF_n = 1 if jnj = jeV j. This reduces the problem to the calculation of the determinants of 4 4 m atrices.

In the zero-tem perature lim it one can work out this idea analytically, and after very lengthy but straightforward algebra, we obtain the following expressions for $P_n^0 \times V$)

$$P_{n}^{0}(\mathbf{E};\mathbf{V}) = \begin{array}{cccc} & \mathbf{W} & \mathbf{$$

Here, we have used again the shorthand $g_n^{A,R}$ (E) $g_n^{A,R}$ (E + neV), and de ned

$$Z_{n} = 1 \frac{p_{\overline{T}}}{2} (g_{(n+1)} g_{n}) \frac{T}{4} (f_{(n+1)})^{2} B_{(n+2)}; n 0;$$
(58)

where = R; A, K = $\begin{pmatrix} Q \\ j=1 \end{pmatrix} \det F_{2j} \begin{pmatrix} Q \\ j=1 \end{pmatrix} \det F_{2j}$ and the di erent functions can be expressed as follows (n 0)

$$B_{n}^{1} = 1 \frac{p_{\overline{T}}}{2_{m}} (g_{n} - g_{(n-1)}) \frac{T}{4} (f_{n})^{2} = Z_{n};$$

$$det F_{n} = \sum_{a, R}^{Y} Z_{n} (1 - \frac{p_{\overline{T}}}{2} (g_{n} - g_{(n-1)})) \frac{T}{4} (f_{n})^{2};$$

$$(59)$$

$$J_{n} = \begin{pmatrix} y_{1} \\ detF_{(n+2j)} \end{pmatrix} \frac{p_{T}}{2} (g_{n}^{A} g_{n}^{R}) Z_{n}^{R} Z_{n}^{A} \frac{T}{4} (f_{n}^{A} f_{n}^{R}) f_{n}^{R} Z_{n}^{A} + f_{n}^{A} Z_{n}^{R} ;$$

Notice that, since at zero tem perature the charge only ows in one direction, only the P_n with n 0 survive. It is worth stressing that the full inform ation about the transport properties of superconducting point contacts is encoded in these probabilities. Let us also remark that $P_n \times V$) are positive numbers bounded, between 0 and 1, and ful llthe norm alization condition $P_n (E; V) = 1$. Thus, we see that for the nite bias dc transport, where the superconducting phase does not play any role, there is no problem with the typical interpretation of P_n as probabilities [47]. Moreover, although at a rst glance the expressions of Eqs. (57-59) look complicated, they can be easily computed and provide the most e cient way to calculate the transport properties of these contacts. In practice, to determ ine the functions $B_n^{A,R}$ and det F_n , one can use the boundary condition $B_n^{A,R} = det F_n = 1$ =jeV j. forjnj

In view of Eqs. (57-59) the probabilities P_n can be interpreted in the following way. P_n is the probability of a MAR of order n, where a quasiparticle in an occupied state at energy E is transmitted to an empty state at energy E + neV. The typical structure of the expression for this probability consists of the product of three terms. First, J_0 gives the probability to inject the incom-ing quasiparticle at energy E. The term $\begin{bmatrix} n & 1 \\ k = 1 \end{bmatrix}$ (T=4) $f_k^A f_j^A$ describes the cascade of n = 1 Andreev referses, in which an electron is referred as a hole and vice versa, gaining an energy eV in each referred as a hole and many J_n gives the probability to inject a quasiparticle in an empty state at energy E + neV. This interpretation is illustrated in

Fig.1, where we show the rst four processes for BCS superconductors. The product of the determ inants in the expression of J_n (see Eq. (59)) describes the possibility that a quasiparticle m akes an excursion to energies below E or above E + neV. In the tunnel regime this possibility is very unlikely and at perfect transparency is forbidden. For this reason the expressions of the MAR probabilities simplify a lot in these two limits, as we discuss in the next paragraphs.

In the tunnel regime a perturbative calculation yields $(n \quad 1)$

$$P_{n}(T = 1) = \frac{T^{n}}{4^{n-1}} \int_{k=1}^{n} f_{k}^{A} f_{j}^{2}; \qquad (60)$$

where (E) is the reservoir density of states. If we use this result in the current expression (see below), we recover exactly the result of the multiparticle tunneling theory of Schrie er and W ilkins [9]. As we mentioned in the introduction, the expression above leads to divergences in the current, which shows that this problem is non-perturbative in the transmission. Thus, even at low transparencies one has to use the full expression of Eqs. (57-59), where the mentioned divergences are regularized in a naturalmanner.

For perfect transparency (T = 1), the absence of norm albackscattering m akes the expressions of the probabilities P_n (E;V) much simpler, and one can show that they can be written as (n 1)

$$P_{n} (T = 1) = \begin{pmatrix} X & 1 & & & \\ (1 & j_{k} & n+1 & j_{l} \end{pmatrix} & & j_{k} & j_{l} & (1 & j_{k} & j_{l} \end{pmatrix};$$

$$I = 0 \qquad \qquad k = n+1+1 \qquad (61)$$

where a(E) is the Andreev rejection coecient defined as $a(E) = if^R(E) = 1 + g^R(E)$, and $a_n = a(E + neV)$. A scan be seen in Eq. (61), a quasiparticle can only move upwards in energy due to the absence of normal rejection. If we use this expression in the current formula we recover the result obtain by K lapwigk, B londer and T inkham [11] for T = 1.

IV. APPLICATION TO DIFFERENT SITUATIONS

As explained in the previous section, with the expression of the MAR probabilities we can easily describe many di erent transport properties. Moreover, notice that so far we have not made any assumption about the leads G reen's functions $g^{A,R}$ and $f^{A,R}$ entering in the expressions of P_n (E;V). Therefore, these expressions allow us to address a great variety of situations. In this section we analyze the zero-tem perature transport properties of three di erent situations: (i) a contact between BCS superconductors, (ii) a contact between superconductor under the in uence of pair-breaking mechanisms and (iii) a short di usive SNS contact, where N is a normal disordered region shorter than the superconducting coherence length.

A. BCS superconductors

Let us start analyzing the most standard situation, namely a contact between two BCS superconductors with a gap . In this case f^{A,R} = i = $(E \quad i \quad j^{2})^{2}$, where = 0⁺, and g^{A,R} follows from normalization. A smentioned in the introduction the current and noise of such a contact have been thoroughly studied both theoretically [15, 16, 17, 18, 21, 22] and experimentally [28, 29, 30, 31, 32]. Our goal here is to show how the know ledge of the FCS provides a new and deeper insight into the di erent transport properties.

In Fig. 2 we show the rst three cumulants of the charge transfer distribution: current, shot noise and skewness (third cumulant). Let us discuss their most remarkable features. (i) The current exhibits the so-called subharmonic gap structure, as discussed in the introduction. This subgap structure evolves from a step-like behavior for low transmission to its disappearance at perfect transparency. (ii) The shot noise in the sub-gap region can be much larger than the Poisson noise (S_{I,Poisson} = 2eI). Moreover, in the tunneling regime the elective charge de ned as the ratio q S_I=2I is quantized in units of the electron charge: q(V) = e =

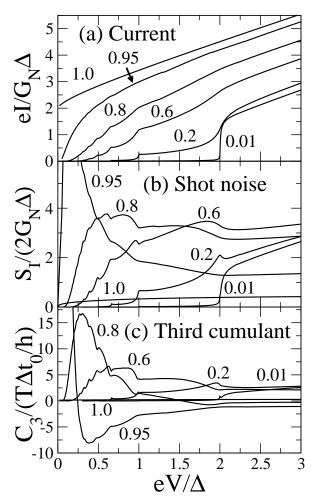


FIG.2: Current, shot noise and third cumulant at zero tem perature as a function of the voltage for BCS superconductors of gap . The di erent curves correspond to di erent transm ission coe cients as indicated in the panels. Here, $G_N = (2e^2=h)T$ is the norm al state conductance.

1 + Int(2 =eV). This is illustrated in Fig. 3, where the ratios $C_2=C_1$ and $C_3=C_1$ are shown as a function of the voltage. (iii) As shown in Fig. 3, the third cumulant at low transm issions is described by $C_3 = q^2C_1$, where again q is the quantized e ective charge de ned above. For higher transm issions this cumulant is negative at high voltage as in the normal state, where $C_3 = (t_0=h)T(1 T)(1 2T)eV$, but it becomes positive at low bias, and after this sign change there is a huge increase of the ratio $C_3=C_1$.

The features described in the previous paragraph can be easily understood with the help of an analysis of the probabilities $P_n (E;V)$. To give an idea about them, in F ig. 4 we have plotted their average value de ned as $P_n (V)$ (1=eV) $_0^{eV}$ dE $P_n (E;V)$ for two very di erent transm issions. First of all, notice that, no matter what the transm ission is, the probability of an n-order MAR has a threshold voltage $eV_n = 2$ =n, below which the process is forbidden. When $V > V_n$ an n-order MAR

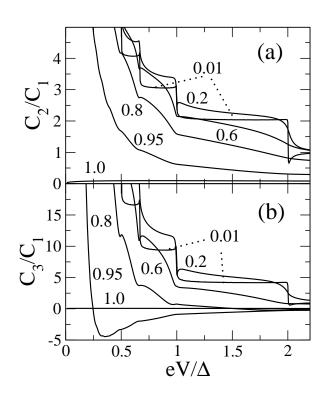


FIG.3: (a) Second cum ulant and (b) third cum ulant at zero tem perature for BCS superconductors. Both are norm alized to the rst cum ulant (the average current). The transm issions are indicated in the plots.

gives a new contribution to the transport, which is nally the explanation of the subharm onic gap structure. On the other hand, the big di erence between the tunneling regime and perfect transparency can be explained as follows. At low transparency there are two factors that make the subgap structure so pronounced. First, at V_n the n-order MAR is a process that connects the two gap edges, where the BCS density of states diverges (see Eq. (60)). This fact, together of course with its higher probability, implies that this MAR rapidily dominates the shape of the I-V curves giving rise to a non-linearity at V_n . Second, at V_n there is a huge enhancement of the probabilities of the MARs of order m > n. This is due to the fact that precisely at $V_{n}\,$ the MAR $\,$ trajectories can connect both gap edges, which as can be seen in Eq. (60) increases enorm ously their probability. At perfect transparency, the MAR probabilities do not exhibit any abrupt feature (see Fig. 4b). This is due to the fact that the BCS density of states is renorm alized, and in particular, the divergences disappear (see Eq. (61)). This fact explains naturally why the subharm onic gap structure is completely washed out at T = 1.

A nother interesting feature of the MAR probabilities occurs at low transparencies. As one can see in Fig. 4a, at a voltage 2 = n < eV < 2 = (n - 1) the MAR of order n has a much higher probability than the other MARs. This means that in this voltage window the n-order MAR clearly dom inates the transport properties and the charge

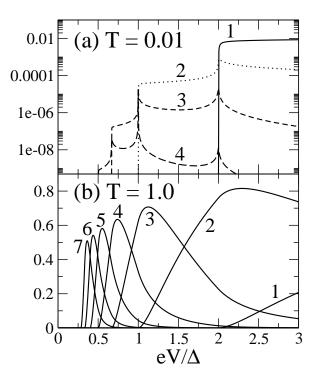


FIG. 4: A verage MAR probabilities $P_n(V)$ (1=eV) $_0^{eV}$ dE $P_n(E;V)$ as a function of voltage for a contact between BCS superconductors at zero temperature. The two panels correspond to two di erent transmissions. The index of the processes is indicated in the plots. Notice the logarithm ic scale in the panel (a).

is predom inantly transferred in packets of ne. This fact explains the charge quantization in the tunnel regime observed both in C₂ and C₃ (see Fig. 3). More generally, this fact implies that at low transparencies the multinom ial distribution of Eq.(19) becomes Poissonian, and in this limit all the cumulants are proportional to the current: $C_n = (q(V)=e)^n C_1$, where q(V) is the voltage-dependent quantized charge. When the transmission is not very low, there are always several MARs that give a signi cant contribution to the transport at every voltage (see Fig. 4b). This explains why the charge is in general not quantized.

The explanation for the sign change of C_3 at low bias and high transparencies can be found in Eq. (23). In order to get a positive value for C_3 , one needs the rst two terms in Eq. (23) to dom inate, which happens when P_n 1. This is precisely what happens at low bias, where the MAR probabilities are rather sm all. On the other hand, the huge enhancem ent after the sign change is due to fact that n, the charge transferred by these MARs, is indeed huge at low bias.

Finally, at T = 1 the cum ulants C_n (with n > 1) do not completely vanish due to the fact that at a given voltage di erent MARs give a signi cant contribution, and therefore their probability is smaller than one (see Fig. 4(b)).

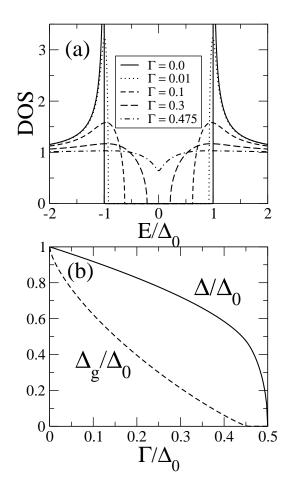


FIG. 5: (a) Density of states as a function of energy of a superconductor for di erent values of the depairing energy measured in units of gap in the absence of pair-breaking $_0$. (b) Order parameter and spectral gap $_g$ in units of $_0$ as a function of the depairing energy normalized by $_0$.

B. Pair-breaking mechanisms

It is well-known that there are many mechanisms that can lead to pair-breaking e ects, which modify the quasiparticle spectrum of a superconductor. Typical examples are a magnetic eld, supercurrents or magnetic impurities. It was shown in the 1960's that for diusive superconductors various pair-breaking mechanisms can be described in a unied manner with a single parameter , the depairing energy, which describes the strength of the pair-breaking [65]. The only di erence between these mechanisms is contained in the microscopic expression of . For instance, for thin a lm of thickness d much smaller than the superconducting coherence length in a magnetic eld H parallel to the lm = $De^2d^2H^2 = (6 - c^2)$, where D is the diusion constant. In these situations the energy-dependent retarded G reen's function can be calculated from [65]

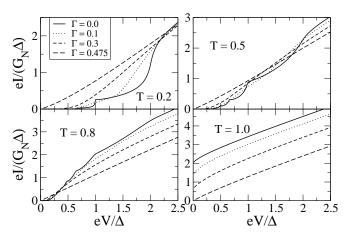


FIG.6: Zero temperature current-voltage characteristics for superconductors with a depairing energy in units of $_0$. The current and the voltage have been normalized with the order parameter at the corresponding. The di erent panels correspond to di erent transmissions values.

$$g^{R} = p \frac{u}{u^{2} - 1} = uf^{R}; \frac{E}{2} = u - 1 - p \frac{1}{1 - u^{2}}$$
 : (62)

Here, is the order parameter, which is in this case differs from the spectral gap and it has to be determined the pair-breaking self-consistently [66]. For small mechanisms result in a smearing of the BCS singularities in the density of states and in a suppression of the spectral energy gap $_{q}$ to a reduced value $_{q}$ = $(=)^{2=3}$ ³⁼². The gap disappears completely at 1 0.45_{0} , where $_{0}$ is the order parameter in the absence of pair-breaking. The gapless superconductivity survives until the critical value $_{\rm C} = 0.5$ 0. This behavior is illustrated in Fig. 5(a), where we show the density of states as a function of energy for di erent values of in units of 0. In Fig. 5(b) one can see the evolution of the order param eter and spectral gap with the depairing energy.

Let us discuss now how this modi ed density of states is relected in the transport properties. In Fig. 6 we show I-Vs for dierent transmissions and dierent values of the depairing energy. The most noticeable features are: (i) the subharm onic gap structure is shifted to voltages eV = 2 $_{q}$ =n, and (ii) the subgap structure progressively disappears as the pair-breaking strength is increased. These features are simple consequences of the evolution of the density of states with . A nyway, one can get a further insight by analyzing the contribution to the current of the individual MAR processes: $I_n = (2e=h)_0^{1}$ $_{\circ}^{\rm V}$ dE P_n (E; V). These quantities are plotted in Fig. 7 for T = 1. As one can see, the threshold voltage for a n-order MAR is now $eV_n = q=2n$ as a consequence of the reduced spectral gap. As the gap dim inishes, the processes of low est order dom inate the I-V s even at low bias. It is interesting to notice that even in a

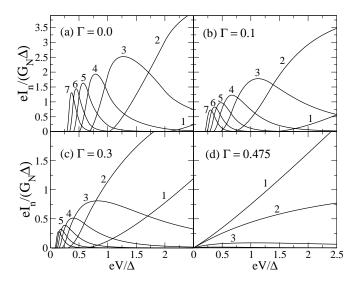


FIG. 7: Current contribution of processes n = 1;2;... for T = 1 as a function of voltage for superconductors with a depairing energy in units of $_0$. The current and the voltage have been norm alized with the order parameter at the corresponding . The order of the processes is indicated in the plots.

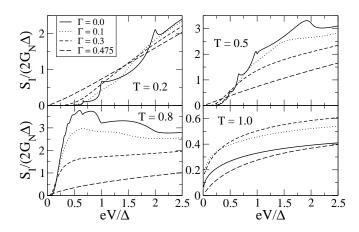


FIG. 8: Zero temperature noise for superconductors with a depairing energy in units of $_0$. The current and the voltage have been normalized with the order parameter at the corresponding . The di erent panels correspond to di erent transm issions values.

gapless situation (= 0.475) there is a nite contribution of the MARs. It is worth mentioning that in Refs. [67] and [68] the type of theory described here accounted for the magnetic eld dependence of the I-V s of atom ic contacts.

Let us turn now our attention to the second and third cum ulants that can be seen in Fig. 8 and Fig. 9, respectively. As in the case of the current, the subharm onic gap structure is shifted and sm oothed as the gap evolves with

. M oreover, one can notice that for high transparencies and in the subgap region there is a great reduction of both cum ulants as increases. This is a consequence of the fact that low order MARs dom inate even at low bias,

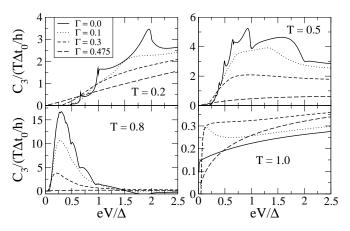


FIG.9: Zero temperature third cum ulant for superconductors with a depairing energy in units of 0. The current and the voltage have been norm alized with the order parameter at the corresponding . The di erent panels correspond to di erent transm issions values.

which in practice means that the charge transferred at these voltages is on average not very big.

C. Diusive SNS contacts

So far we have discussed the case of a single channel contact. The results are trivially generalized to the multichannel case by introducing a sum over the conduction channels. In this subsection we brie y address the case of a short di usive SNS junction with a large number of transm ission channels and di usive electron transport in the normal N region. The superconducting leads are considered as BCS superconductors. In this case, the distribution of transm ission coe cients is continuous, and it is characterized by the density function (T), which has the well-known bin odal form [69]

$$(T) = \frac{G_N}{2G_0} \frac{p}{T} \frac{1}{1 - T};$$
(63)

where G_N is the normal-state conductance of the N region ad $G_0 = 2e^2$ =h is the conductance quantum. Then, the di erent cum ulants can be calculated from the single-channel results C_n (T) as follows

$$C_n = dT (T)C_n (T):$$
 (64)

In Fig.10 (a) we show the rst three cum ulants for this SNS system. Both the current and the noise have previously discussed in the literature [22, 70], and here we recover these results. Both quantities exhibit a subharmonic gap structure which is a result of the competition of channels with di erent transparencies. Again, this structure can be understood by analyzing the individual contributions to the current of the di erent MARs,

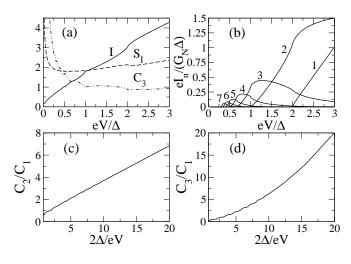


FIG.10: Zero temperature transport properties of a short di usive SNS junction. (a) First three cum ulants: current in units of ($G_N = e$), shot noise in units of ($2G_N$) and the third cum ulant in units of ($G_N = t_0=hG_0$). (b) Current contribution of the di erent processes. (c) Ratio $C_2=C_1$ as a function of the inverse of the voltage. (d) Ratio $C_3=C_1$ as as a function of the inverse of the voltage.

see Fig. 10(b). As one can see, at every voltage there are several processes giving a signi cant contributions, which makes that subgap structure much sm oother than in the single-channel case. This fact also explains the absence of the charge quantization in this multichannel case. This is illustrated in Fig. 10(c), where we show the ratio $C_2=C_1$ as a measure of the elective charge. Notice that at low bias this e ective charge grows as (1=V) as obtained in Ref. [22]. In this regime the numerical results can be approximately described by the following linear function: $C_2=C_1 = 0.31(2 = eV) + 0.55$. On the other hand, the third cumulant exhibits a huge increase at low voltages [35]. In particular, as shown in Fig. 10(d), the ratio $C_3=C_1$ grows as $(1=V)^2$ at low bias. In this regime the ratio can be approximated by $C_3 = C_1 = 0.05 (2 = eV)^2 + 0.5$.

V. TRANSPORT PROPERTIES AT FINITE TEM PERATURES

So far we have discussed the transport properties of superconducting point contacts at zero tem perature. In this section we shall investigate the role of the tem perature, which we shall denote as T_e . We focus our attention to the case of a single channel contact between BCS superconductors. At nite tem perature it is not easy to determ ine analytically the probabilities P_n (E;V), and in this case we have calculated them numerically. The idea goes as follows. A coording to Eq. (18) we need to calculate the coe cients P_n^0 (E;V), which are simply the

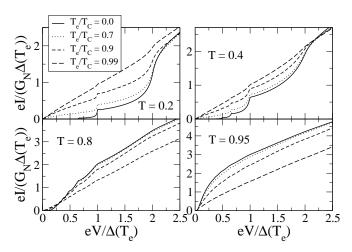


FIG.11: Current-voltage characteristics at nite temperature for BCS superconductors. The temperature is in units of the critical temperature T_c . The current and the voltage are norm alized with the temperature-dependent gap. The di erent panels correspond to di erent transm ission values.

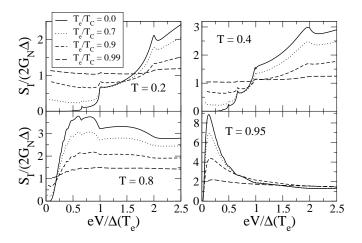


FIG.12: Finite tem perature noise for BCS superconductors. The tem perature is norm alized with the critical tem perature $T_{\rm C}$. The di erent panels correspond to di erent transm ission values. The voltage is norm alized with the tem perature-dependent gap, and the current with the zero-tem perature gap. Note that the scaling is di erent from the other plots in this section.

Fourier coe cients of the series in Eq. (18), i.e.

$$P_{n}^{0}(E;V) = \frac{1}{2} \int_{0}^{Z_{2}} de^{in} detQ(): \quad (65)$$

Finally, detQ () is calculated num erically. Of course, if one is only interested in the di erent cum ulant, one can easily calculate them by taking the num erical derivative of the CGF, see Eq.2.

In Figs. 11,12, and 13 we show the current, noise and third cumulant, respectively, for di erent transmission and tem peratures ranging from zero to the critical one. Notice that in order to get rid of the trivial tem perature

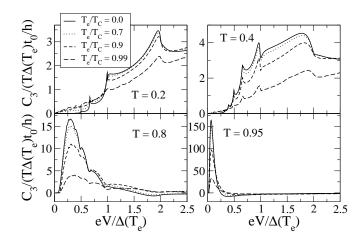


FIG.13: Finite temperature thrid cum ulant for BCS superconductors. The temperature is normalized with the critical temperature $T_{\rm C}$. The di erent panels correspond to di erent transmission values. The third cum ulant and the voltage are normalized with the temperature-dependent gap.

dependence due to the decrease of the gap we have norm alized the voltage by the tem perature-dependent gap

(T_e). A sit can be seen in Fig. 11, the tem perature progressively sm oothes the SG S and increases the current for low transm issions. These are simple consequences of the therm al excitation of quasiparticles. For higher transm issions the tem perature has the opposite e ect (see the lower two panels in Fig. 11). The current decreases with increasing tem perature and approaches the norm al state current-voltage characteristic from above. At the sam e tim e the excess current, i.e. I (V =e) G_NV, vanishes obviously. So in short, by increasing the tem perature high-order Andreev re ections contribute less to the current, which is dom inated by therm ally activated direct quasiparticle tunneling. This behavior is clearly illustrated in Fig. 14, where we show the evolution with the temperature of the average probability $(1=eV)_{0}^{R_{eV}}$ dE P_n (E;V) of dierent processes ${\tt P}_n$ (V) for a contact with transmission T = 0.95. Notice that we only show the rst electron processes that give a positive contribution to the current. Remember that at nite tem perature there are also hole processes that give a negative contribution to the current, the magnitude of which is still much smaller than the one of the electron processes in the shot noise lim it eV k_BT. At vanishing voltages, of course, $P_n = P_n$ as required by the uctuation-dissipation theorem .

In Fig. 14 one can observe the following in portant features. First, at nite temperature the di erent processes do not have any nite threshold voltage, and they can contribute down to zero bias due to them al activation. Second, as the temperature increases the probability of the single quasiparticle processes is greatly enhanced inside the gap. This fact results in a reduction of the average e ective charge transmitted through the contact. Finally, notice that although the MAR probabilities are

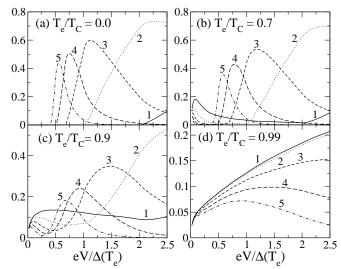


FIG. 14: A verage MAR probabilities $P_n\left(V\right)$ $\left(1\!=\!eV\right)_{0}^{R_{eV}}$ dE $P_n\left(E\;;V\right)$ at nite temperature as a function of voltage for a contact between BCS superconductors with transmission T = 0.95. The four panels correspond to different temperatures T_e expressed in units of the critical tem – perature T_c . The index of the processes is indicated in the plots.

reduced inside the gap at nite tem perature, high-order processes can give a signi cant contribution to the transport even at voltages larger than the gap at the corresponding temperature. This is clearly at variance with the zero tem perature case. To understand this behavior, let us recall that the total voltage gain for an order n process is neV, which means essentially that higher order processes can start well below the gap and end well above the gap. Now, at nite tem perature e.g. the end states above the gap are lled with nite probability f (E + neV), assuming that the process has started with a quasiparticle at energy E . A certain process can only happen if its nalstate is empty. This gives a factor f (E + neV), which enhances the chance for higher 1 order processes, since they have to end up at higher energies, for which this factor is larger. On the other hand, a sim ilar argum ent can be made about the initial state, which has to be led for the process to take place. A gain, this is more likely for higher order processes, since they can emerge from energies well below the gap, which are completely lled also at nite tem perature.

It is interesting to discuss the qualitative di erent tem perature behavior of the second and third cumulants. The noise exhibits a transition from pure shot noise at zero temperature to them al noise when the temperature is larger than the voltage. As it can be seen in Fig. 12, this transition is relected in a saturation of the noise at low bias to a nite value, which is given by the uctuation-dissipation theorem. It is interesting to note, that the noise decreases as a function of voltage in the transition region from them al to shot noise also for relatively sm all transmissions. Such a behavior can be at-

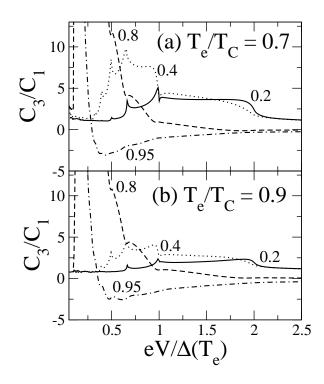


FIG.15: Ratio $C_3=C_1$ for two di erent temperatures as a function of the voltage for a contact between BCS superconductors. The di erent curves correspond to di erent transmissions as indicated in the plots.

tributed to the multinom ial distribution. Interestingly, from Eq. (28) we see that the correlations between processes of orders with opposite sign (e.g m = n) tend to increase the noise. As these terms appear only if the respective probabilities are non-negligible, the reduction of noise below the therm al level can be understood as consequence of the vanishing cross correlations between processes of orders with di erent signs.

The tem perature dependence of the third cum ulant is very interesting. First we recall that the third cum ulant vanishes at zero voltage for any tem perature (as all odd cum ulants do). In Ref. [45] the tem perature dependence of the third cumulant for a quantum contact between norm alm etals was calculated. It was shown, that an increasing transparency has quite a dram atic e ect on the third cumulant. For a tunnel junction (i.e. for small transm ission) C_3 is independent of the tem perature and it is simply equal to the $q^2 C_1$. However, this is interesting because it allows a direct measurement of the charge q transfered in an elementary event even for voltages below the shot noise lim it. Note, that this relation holds also for non-linear current-voltage characteristics, since it is a consequence of the bidirectional Poisson distribution in this lim it. The e ects of a nite transparency are even m ore dram atic. The third cum ulant has a m arked tem perature dependence, crossing over from a F I dependence, where F = 1 T is the Fano factor, to a novel high-tem perature dependence FI(1 2T), which can even become negative for T > 1=2. In view of these ndings, we will now discuss our results for the tem perature dependence of the third cum ulant of a superconducting point contact.

First, we note that in Fig. 13 C_3 has a temperature dependence even in the tunnel regime. As explained in the previous paragraph, this in contrast with the norm al state, where C₃ is almost independent of the tem perature, as it has been discussed theoretically in Ref. [45] and observed experim entally in Ref. [71]. In our case the tem perature dependence is due to the change in the MAR probabilities caused by the therm al activation. As explained above, the therm alactivation enhances the probability of the tunneling of single quasiparticles inside the gap, which in turn reduces the average e ective charge. A consequence of this fact is the great reduction of the ratio $C_3=C_1$ as the tem perature increases. This is illustrated in Fig 15. This reduction is specially dram atic in the subgap region for high transparencies, as it can be seen directly in Fig. 13.

VI. CONCLUSIONS

W e have presented a detailed analysis of the full counting statistics in superconducting point contacts at nite bias voltage. We have demonstrated that the charge transfer in these systems is described by a multinom ial distribution of processes, in which multiple charges ne (with $n = 1;2;3; \dots; 20; \dots$) are transferred through the contact. These processes are nothing but multiple Andreev re ections. The know leade of the full counting statistics allows us to obtain the probabilities of the individualMARs, providing so a deep insight into the electronic transport of these junctions. From the know ledge of these probabilities one can easily calculate not only the current or the noise, but all the cum ulants of the current distribution. We have also shown that one can obtain analytical expressions for the MAR probabilities at zero tem perature, which provides the most e cient method to calculate the transport properties of these contacts. M oreover, the FCS approach allow sus to describe a great variety of situations in a uni ed m anner.

In this sense, we have addressed di erent situations such as contacts between BCS superconductors, junctions between superconductors where a pair-breaking mechanism ist acting or short di usive SNS contacts. We have also discussed the temperature dependence of the rst cumulants and illustrated their peculiarities as compared with the norm all case. It is also worth mentioning that the form alism developed in this work can be easily applied to other situations not addressed here such as point contacts with proxim ity-e ect superconductors [72] and Josephson junctions of unconventional superconductors [73, 74].

From the full counting statistics view, we have found a new distribution occuring in superconducting point contacts. The statistics takes the form of a multinom ial distribution of charge transfers of all orders, which are allowed by the applied bias voltage. We have shown, that the lim it of opaque contacts provides an interesting situation, in which Poissonian statistics makes it possible to observe multiple charge transfers in a direct manner. Furthermore, we have discussed consequences of the multinom ial statistics of charge transfers of di erent sizes at the same time. For example, an open contact has a nite noise due to the presence of di erent MAR processes at the same time. The temperature dependence of the counting statistics provides a new insight in the transport characteristic, since we have shown that higher order Andreev processes contribute also at voltages much larger than the superconducting gap.

Finally we remark, that the FCS approach provides a

fresh view of the electronic transport of superconducting point contacts and it is seem s to be a natural choice for future theoretical analyses. On the other side, superconducting contacts show an interesting new counting statistics, namely a multinom ial distribution, and we expect further intersting results in other superconducting system s out of equilibrium.

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